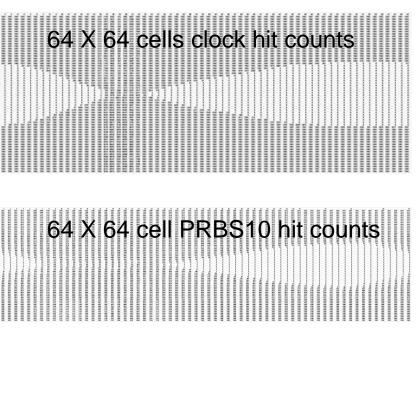
How to Build Signal Eye Diagram

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Eye Opening Monitor (EOM) description

- The LMH12XX on-chip Eye Opening Monitor (EOM) is used to analyze and diagnose the post-equalized waveform which is sampled in the phase and voltage domain across one unit interval
- The phase and voltage range is divided into 64 steps each. This results in an eye capture of 64 x 64 cells, with each cell specifying voltage and phase which indicates the number of hits relative to the main reference incoming eye diagram
- The number of hits registered at each point should be taken in context with the total number of bits observed at that voltage and phase offset to determine the corresponding probability for that point.



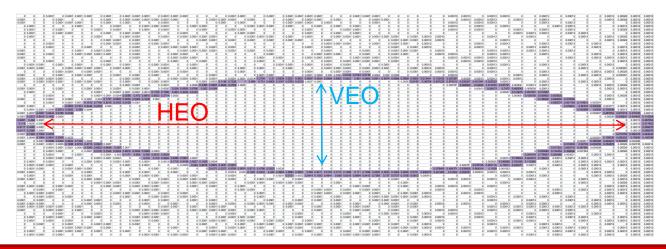
Eye-opening numerical representation: HEO / VEO

Horizontal Eye Opening (HEO):

- The value reported by LMH12xx should be converted to a decimal and then divided by 64. For example, If HEO is 0 x 20 or 32 decimal, therefore, we have 32/64 = 0.5 UI eye opening

Vertical Eye Opening (VEO):

The value should be multiplied by 3.125 mV
 For example, if VEO is 0 x 40 or 64 d; therefore, 64 d * 3.125 = 200 mV VEO

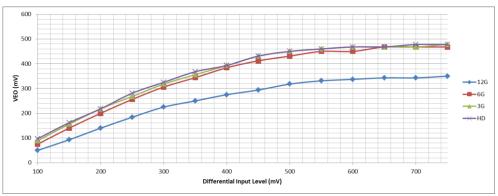


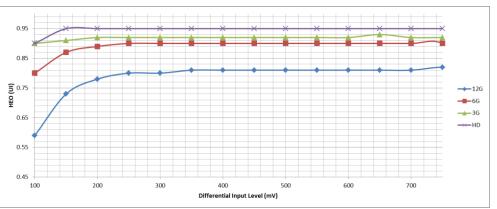
HEO / VEO parameters are a good indication of incoming signal eye quality



LMH1297 VEO vs. actual differential input level

- Key take away:
 - VEO is more linear at lower input voltage swing
 - VEO is a figure of merits
 - HEO/VEO is higher for lower rates
 - Jitter tolerance is 0.6 to 0.55UI:
 - Error Free operation: HEO>0.45





BERT -> LMH1297EVM INO Manual CTLE = 0x00

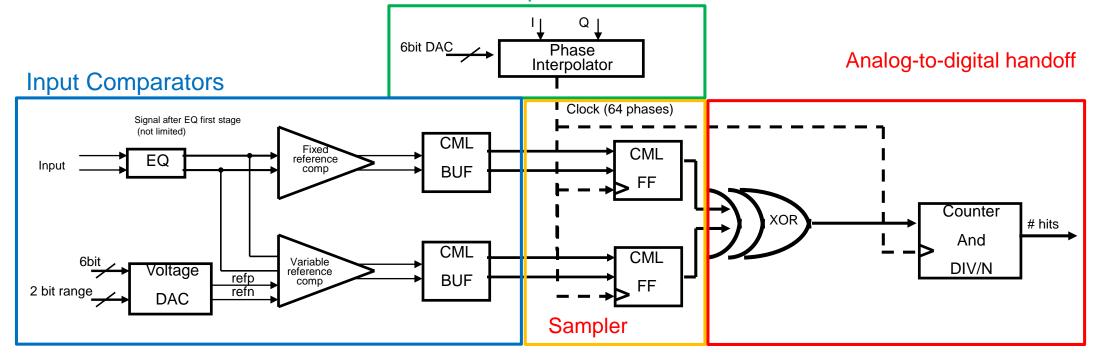
Error free operation when VEO > 150 mV AND HEO > 0.45 UI



Detailed Block Diagram

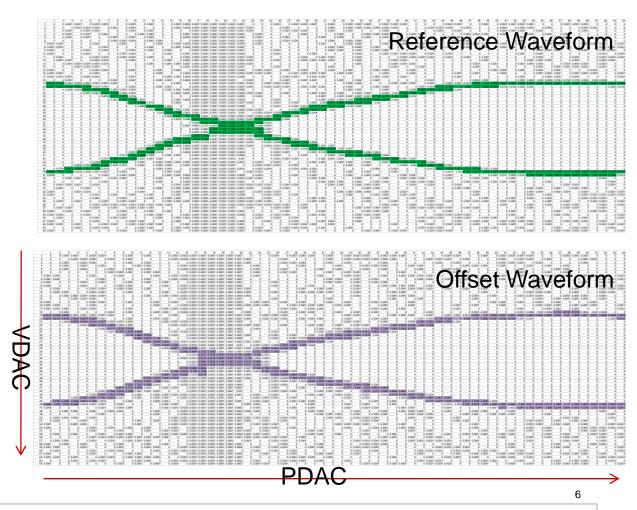
- DAC controlled offset for variable comparator (<u>VDAC</u>)
- Comparison with fixed comparator (offset = 0) determines voltage level
- Variable and fixed comparators are sampled and compared
- Sweeping phase of sampling point using Phase interpolator (<u>PDAC</u>) determines zero crossing
- XOR is sampled and divided down for handoff to digital
- N full-rate "hits" overflow output counter and send digital toggle

Phase Interpolator



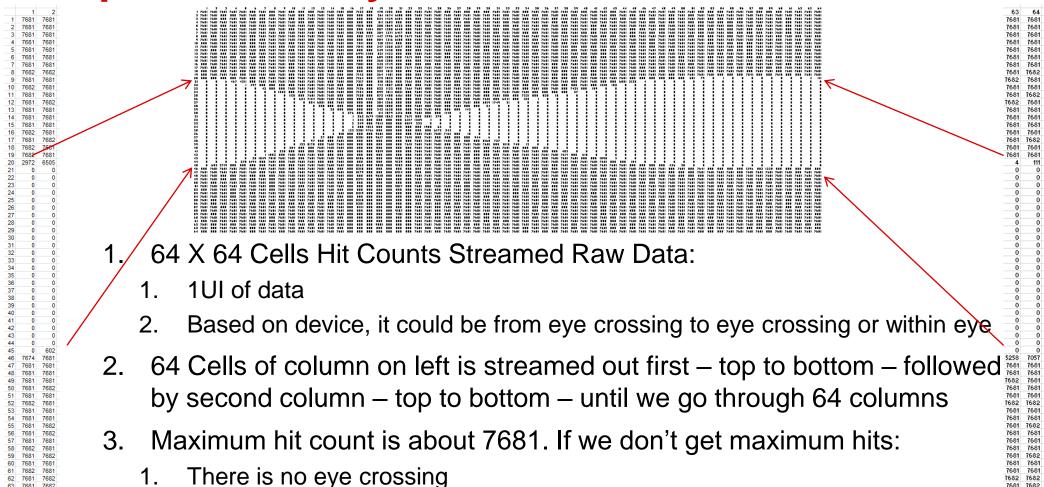
How eye-opening capture works

- Offset waveform PDAC is held constant while VDAC is swept from lowest to highest value
- Next PDAC is increased by one step and again VDAC is swept across its range
- 3) This continues until 64 X 64 (or 4096) cells are recorded.
- 4) Number of hits where two waveforms are overlapped are counted as hits



Clock pattern fast eye data stream format

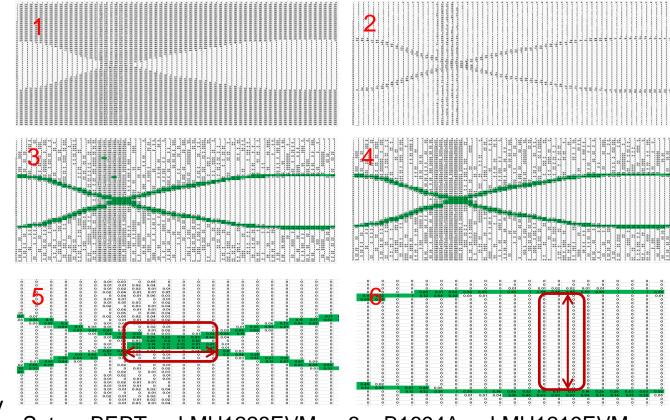
Or range register setting is too low



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12G 1010.. Clock pattern fast EOM data

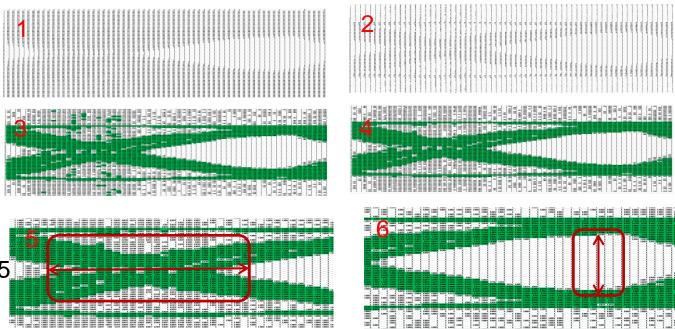
- Raw 64 X 64 EOM raw data
- 2. Hit count subtracted from next vertical cell
- 3. Normalized by maximum hit count
- Cleanup hits due to limited sampling rate
- 5. HEO Calculation:
 - 1. Jitter = 6 columns = 6/64 ~ 0.1
 - 2. HEO = 1 0.1 = 0.9UI
- VEO Calculation:
 - 1. VEO = 28 Rows X 12.5 mV = 350 mV
 - 1. Vrange reg 0x11 = 12.5mV per step



Setup: BERT -> LMH1228EVM -> 3m B1694A -> LMH1219EVM

12G PRBS10 50m B1694A pattern fast EOM data

- Raw 64 X 64 EOM raw data
- 2. Hit count subtracted from next cell
- 3. Normalized by maximum hit count
- Processed hits due to limited sampling rate
- HEO Calculation:
 - Jitter = 22 columns = 22/64 = 0.0.35
 - 2. HEO = 1 0.35 = 0.65UI
- 6. VEO Calculation:
 - 1. VEO = 25 Rows X 12.5mV = 312mV
 - 1. Vrange reg 0x11 = 12.5mV per step



Setup: BERT -> LMH1228EVM -> 50m B1694A -> LMH1219EVM

Eye Diagram Hit Count Processing

- For visual observation, hit count can be normalized and scaled
- Reg 0x2A content indicates length of time to capture hit counts per cell
 - Hit count duration per cell = 256*reg 1218. 0x2A(decimal)*(32/data rate)
 - Example: 11.88Gbps, reg 0x2A = 0x30 = 48 Decimal
 - Hit counts duration per cell = 256*48*(32/11.88E9)=33uS
 - Total time to capture 64X64 = 4096 cells = 4096*33uS = 135mS

Summary

- On-chip Eye Opening Monitor (EOM) is used to analyze and diagnose the postequalized waveform and this is used as a guideline for analyzing signal integrity during development or remote diagnostics
- EOM Capture can be used while user data is going through the device
- HEO/VEO can be optioned to cause interrupt when certain a threshold is reached
- Please refer to the programming guide for detailed HEO / VEO and Eye Opening Monitor detailed register settings



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